

<b>Notice of References Cited</b>	Application/Control No. 10/589,729		Applicant(s)/Patent Under Reexamination OHTSUKI ET AL.	
	Examiner Michael Mapa		Art Unit 2617	Page 1 of 1

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*	B	US-2004/0054691	03-2004	Sharma et al.	707/104.1
*	C	US-2004/0015498	01-2004	Rabaioli, Giovanni	707/9
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	K	US-			
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**NON-PATENT DOCUMENTS**

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